## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10661534	KATAYAMA ET AL.
Examiner	Art Unit
DEVONA E FAULK	2615

SEARCHED							
Class	Subclass	Date	Examiner				
381	105,104,106,102	3/29/07	DEF				
381	311,105,104,311	9/29/07	DEF				
455	41.2,420,430	4/11/08	DEF				
381	102-109,311	7/28/08	DEF				
455	420,430,41.2	7/28/08	DEF				

SEARCH NOTES					
Search Notes	Date	Examiner			
Assignee/Inventor Search	3/29/07	DEF			
combined class/word search 381/102-109	3/29,31/07	DEF			
Additional search	9/29/07	DEF			
Reviewed applicant's arguments; maintained rejection	4/11/08	DEF			
Additional search	4/11/08	DEF			
Consulted with Nghi Han Ly of class 455, suggested 455/41.2,420 and 430	4/11/08	DEF			
additional search	7/28/08	DEF			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
381	104-106,102	3/29/07	DEF		
455	41.2,420,430	4/11/08	DEF		

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